## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SETHI ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0125580	06-2005	Madukkarumukumana et al.	710/200
	В	US-6,908,038	06-2005	Le, Trung V.	235/492
	С	US-6,615,303	09-2003	Endo et al.	710/260
	D	US-6,883,053	04-2005	Shinagawa et al.	710/263
	E	US-2005/0078694	04-2005	Oner, Koray	370/412
	F	US-2005/0097356	05-2005	Zilliacus et al.	713/201
	G	US-6,549,930	04-2003	Chrysos et al.	718/104
	Н	US-6,694,428	02-2004	Lemke et al.	713/1
	1	US-6,704,823	03-2004	Perez et al.	710/260
	J	US-2003/0097503	05-2003	Huckins, Jeffrey L.	710/104
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	α					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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